

n-Channel Power MOSFET

OptiMOS™
BSC0904NSI

Data Sheet

2.2, 2011-09-23
Final

Industrial & Multimarket

1 Description

OptiMOS™30V products are class leading power MOSFETs for highest power density and energy efficient solutions. Ultra low gate and output charges together with lowest on state resistance in small footprint packages make OptiMOS™ 30V the best choice for the demanding requirements of voltage regulator solutions in Servers, Datacom and Telecom applications. Super fast switching Control FETs together with low EMI Sync FETs provide solutions that are easy to design in. OptiMOS™ products are available in high performance packages to tackle your most challenging applications giving full flexibility in optimizing space, efficiency and cost. OptiMOS™ products are designed to meet and exceed the energy efficiency and power density requirements of the sharpened next generation voltage regulation standards in computing applications.

Features

- Optimized SyncFET for high performance buck converters
- 100% avalanche tested
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5\text{ V}$
- N-channel
- Qualified according to JEDEC¹⁾ for target applications
- Superior thermal resistance
- Pb-free plating; RoHS compliant
- Halogen-free according to IEC61249-2-21
- Integrated monolithic Schottky-like diode

Applications

- On board power for server
- Power managment for high performance computing
- Synchronous rectification
- High power density point of load converters

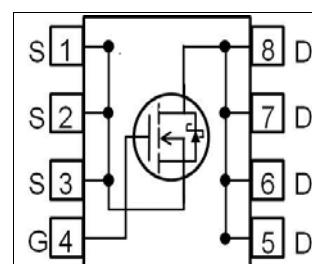
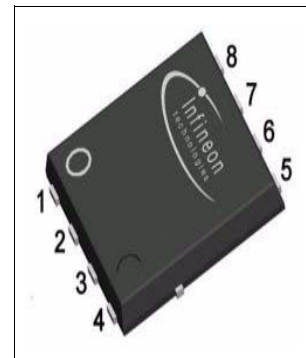


Table 1 Key Performance Parameters

Parameter	Value	Unit	Related Links
V_{DS}	30	V	IFX OptiMOS webpage IFX OptiMOS product brief IFX OptiMOS spice models IFX Design tools
$R_{DS(on),max}$	3.7	mΩ	
I_D	78	A	
Q_{OSS}	12	nC	
$Q_{g,typ}$	17		

Type	Package	Marking
BSC0904NSI	PG-TDSON-8	0904NSI

1) J-STD20 and JESD22

2 Maximum ratings

at $T_j = 25\text{ °C}$, unless otherwise specified.

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current	I_D	-	-	78	A	$V_{GS}=10\text{ V}$, $T_C=25\text{ °C}$
		-	-	49		$V_{GS}=10\text{ V}$, $T_C=100\text{ °C}$
		-	-	66		$V_{GS}=4.5\text{ V}$, $T_C=25\text{ °C}$
		-	-	41		$V_{GS}=4.5\text{ V}$, $T_C=100\text{ °C}$
		-	-	20		$V_{GS}=10\text{ V}$, $T_A=25\text{ °C}$, $R_{thJA}=50\text{ K/W}^{1)}$
Pulsed drain current ²⁾	$I_{D,pulse}$	-	-	312		$T_C=25\text{ °C}$
Avalanche current, single pulse ³⁾	I_{AS}	-	-	30		
Avalanche energy, single pulse	E_{AS}	-	-	14	mJ	$I_D=30\text{ A}$, $R_{GS}=25\text{ }\Omega$
Gate source voltage	V_{GS}	-20	-	20	V	
Power dissipation	P_{tot}	-	-	37	W	$T_C=25\text{ °C}$
		-	-	2.5		$T_A=25\text{ °C}$, $R_{thJA}=50\text{ K/W}^{1)}$
Operating and storage temperature	T_j, T_{stg}	-55	-	150	°C	
IEC climatic category; DIN IEC 68-1		55/150/56				

1) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

2) See figure 3 for more detailed information

3) See figure 13 for more detailed information

3 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	3.4	K/W	
		-	-	20		top
Device on PCB	R_{thJA}	-	-	50		6 cm ² cooling area ¹⁾

1) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air

4 Electrical characteristics

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified.

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	30	-	-	V	$V_{GS}=0\text{ V}$, $I_D=10\text{ mA}$
Breakdown voltage temperature coefficient	$dV_{(BR)DSS}/dT_j$	-	15	-	mV/k	$I_D=10\text{ mA}$, reference to 25 °C
Gate threshold voltage	$V_{GS(th)}$	1.2	-	2		$V_{DS}=V_{GS}$, $I_D=250\text{ }\mu\text{A}$
Zero gate voltage drain current	I_{DSS}	-	-	0.5	mA	$V_{DS}=24\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$
		-	1	-		$V_{DS}=24\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ °C}$
Gate-source leakage current	I_{GSS}	-	10	100	nA	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	4.2	5.2	m Ω	$V_{GS}=4.5\text{ V}$, $I_D=30\text{ A}$,
		-	3.1	3.7		$V_{GS}=10\text{ V}$, $I_D=30\text{ A}$,
Gate resistance	R_G	-	0.9	-	Ω	
Transconductance	g_{fs}	43	86	-	S	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=30\text{ A}$

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	1100	-	pF	$V_{GS}=0\text{ V}$, $V_{DS}=15\text{ V}$, $f=1\text{ MHz}$
Output capacitance	C_{oss}	-	460	-		
Reverse transfer capacitance	C_{rss}	-	64	-		
Turn-on delay time	$t_{d(on)}$	-	3.3	-	ns	$V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=30\text{ A}$, $R_G=1.6\text{ }\Omega$
Rise time	t_r	-	4.4	-		
Turn-off delay time	$t_{d(off)}$	-	16	-		
Fall time	t_f	-	3	-		

Electrical characteristics
Table 6 Gate charge characteristics¹⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	2.9	-	nC	$V_{DD}=15\text{ V}$, $I_D=30\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$
Gate charge at threshold	$Q_{g(th)}$	-	1.7	-		
Gate to drain charge	Q_{gd}	-	2.9	-		
Switching charge	Q_{sw}	-	4.1	-		
Gate charge total	Q_g	-	8.5	-		
Gate plateau voltage	$V_{plateau}$	-	2.7	-	V	
Gate charge total	Q_g	-	17	-	nC	$V_{DD}=15\text{ V}$, $I_D=30\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$
Gate charge total, sync. FET	$Q_{g(sync)}$	-	6.8	-		$V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }4.5\text{ V}$
Output charge	Q_{oss}	-	12	-		$V_{DD}=15\text{ V}$, $V_{GS}=0\text{ V}$

1) See figure 16 for gate charge parameter definition

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_s	-	-	37	A	$T_C=25\text{ °C}$
Diode pulse current	$I_{s,pulse}$	-	-	148		
Diode forward voltage	V_{SD}	-	0.56	0.7	V	$V_{GS}=0\text{ V}$, $I_F=3\text{ A}$, $T_j=25\text{ °C}$
Reverse recovery charge	Q_{rr}	-	2	-	nC	$V_R=15\text{ V}$, $I_F=I_s$, $di_F/dt=400\text{ A}/\mu\text{s}$

5 Electrical characteristics diagrams

Table 8

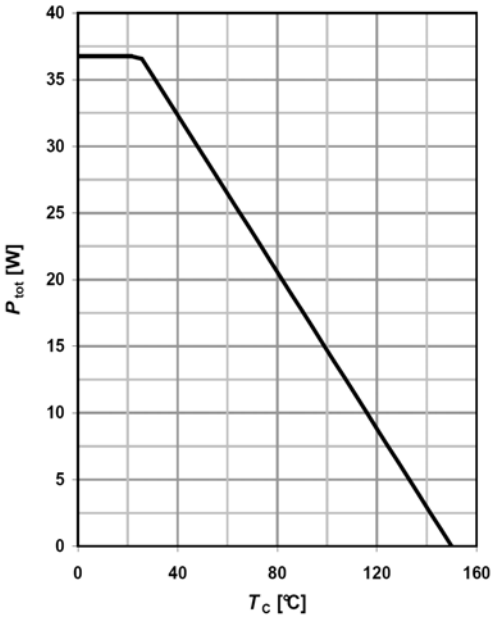
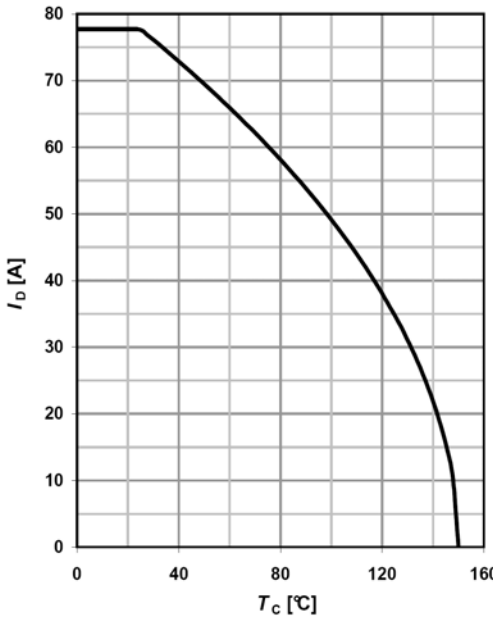
1 Power dissipation	2 Drain current
 $P_{\text{tot}} = f(T_c)$	 $I_D = f(T_c)$; parameter: V_{GS}

Table 9

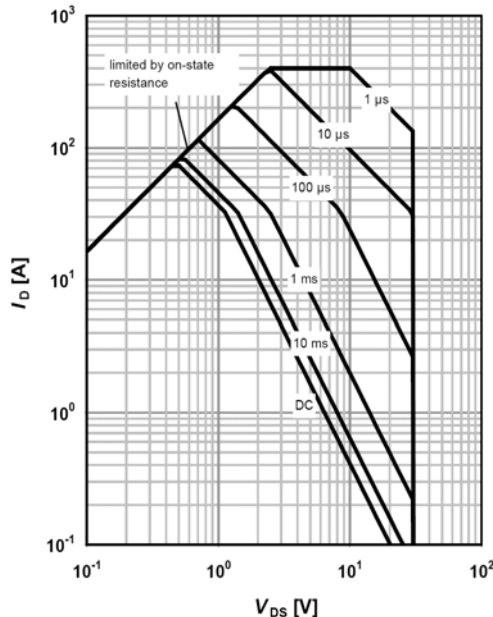
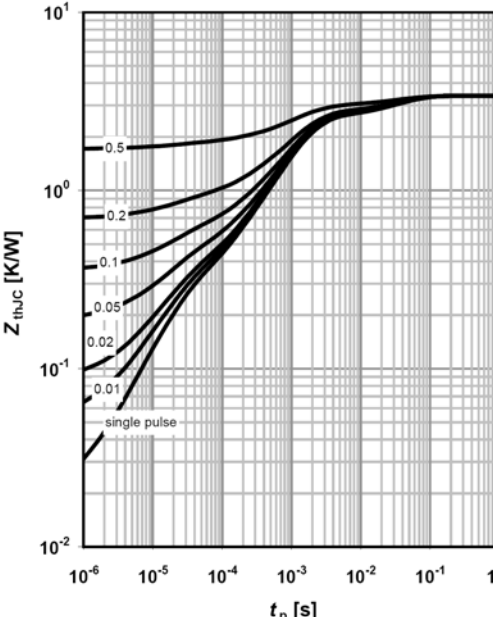
3 Safe operating area $T_c=25\text{ °C}$	4 Max. transient thermal impedance
 $I_D = f(V_{DS})$; $T_j = 25\text{ °C}$; $D=0$; parameter: T_p	 $Z_{(thJC)} = f(t_p)$; parameter: $D = t_p / T$

Table 10

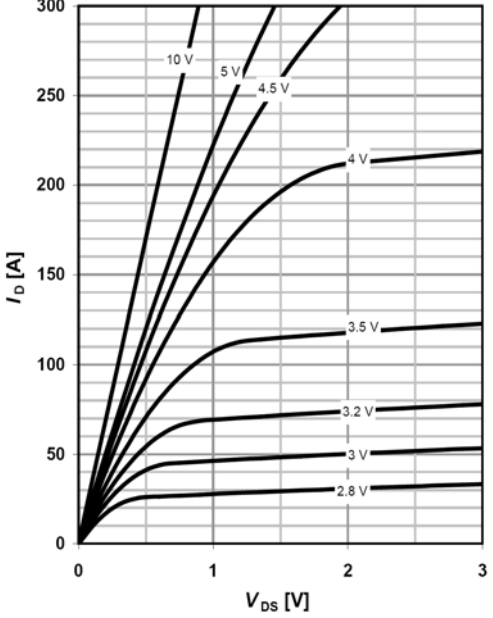
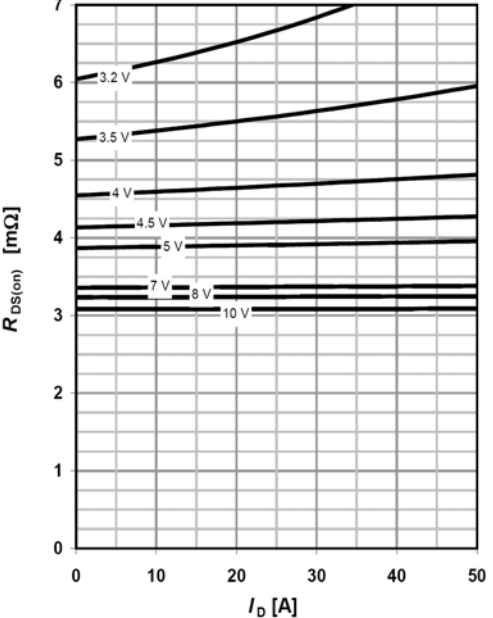
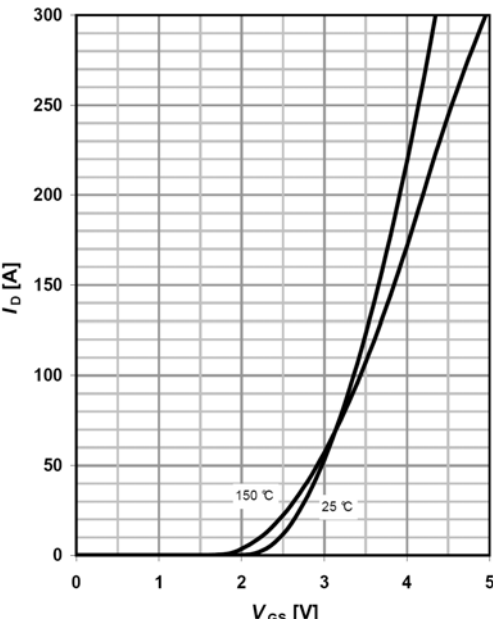
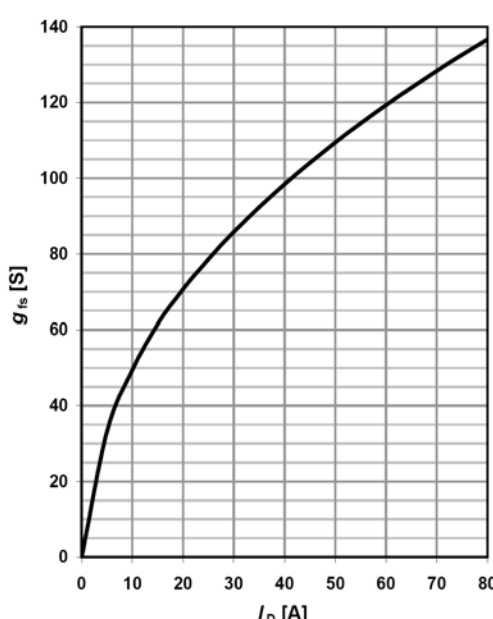
5 Typ. output characteristics $T_c=25\text{ °C}$	6 Typ. drain-source on-state resistance
 $I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$	 $R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

Table 11

7 Typ. transfer characteristics	8 Typ. forward transconductance
 $I_D = f(V_{GS}); V_{DS} > 2 I_D R_{DS(on)max}$	 $g_{fs} = f(I_D); T_j = 25\text{ °C}$

Electrical characteristics diagrams

Table 12

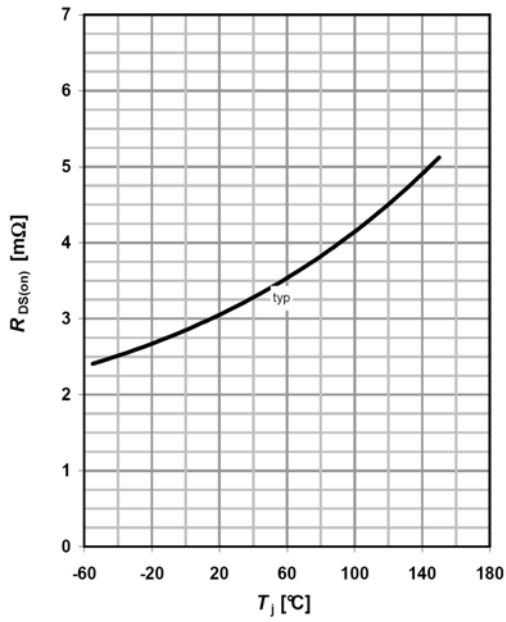
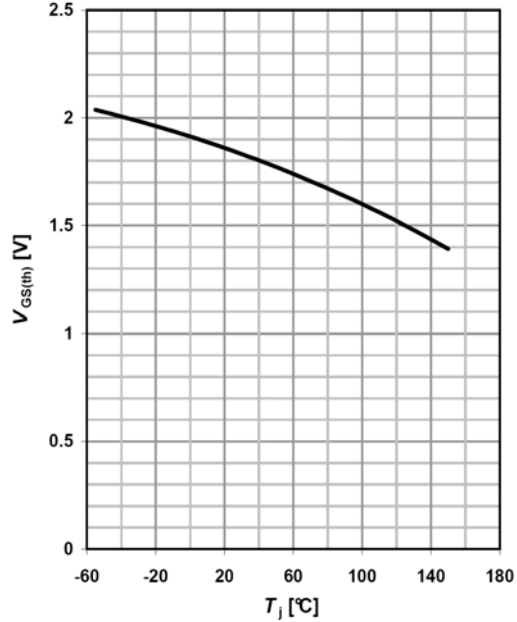
9 Drain-source on-state resistance	10 Typ. gate threshold voltage
	
$R_{DS(on)} = f(T_j)$; $I_D = 30\text{ A}$; $V_{GS} = 10\text{ V}$	$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$; $I_D = 10\text{ mA}$

Table 13

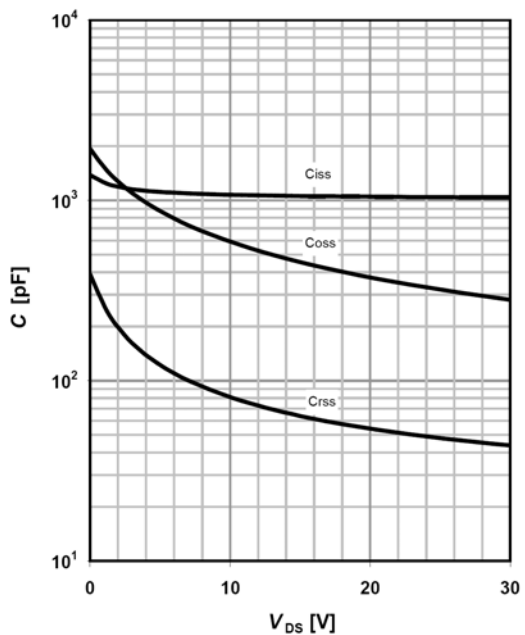
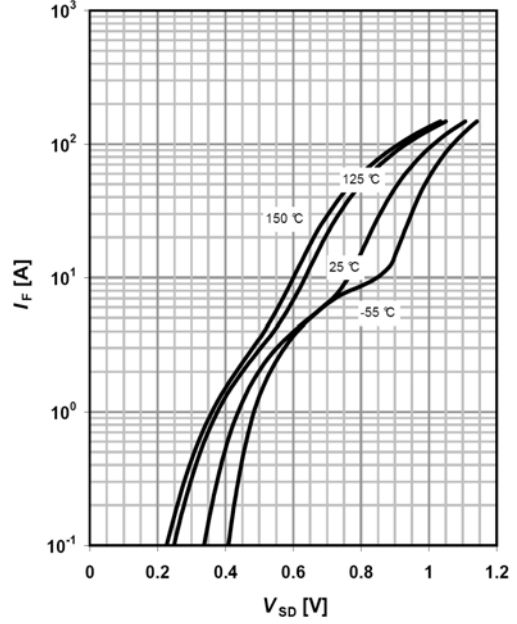
11 Typ. capacitances	12 Forward characteristics of reverse diode
	
$C = f(V_{DS})$; $V_{GS} = 0\text{ V}$; $f = 1\text{ MHz}$	$I_F = f(V_{SD})$; parameter: T_j

Table 14

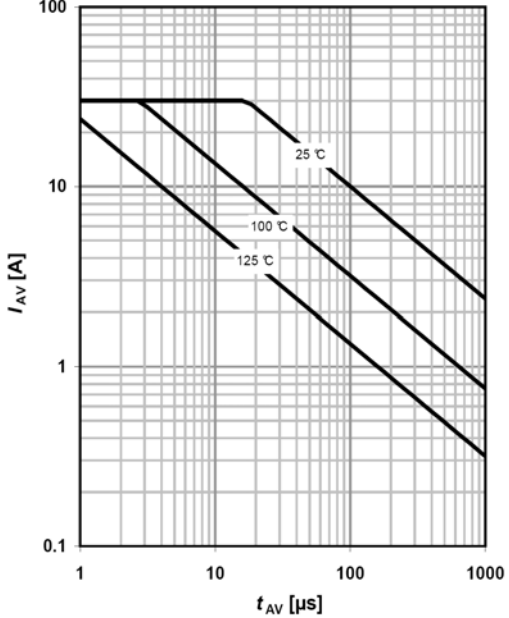
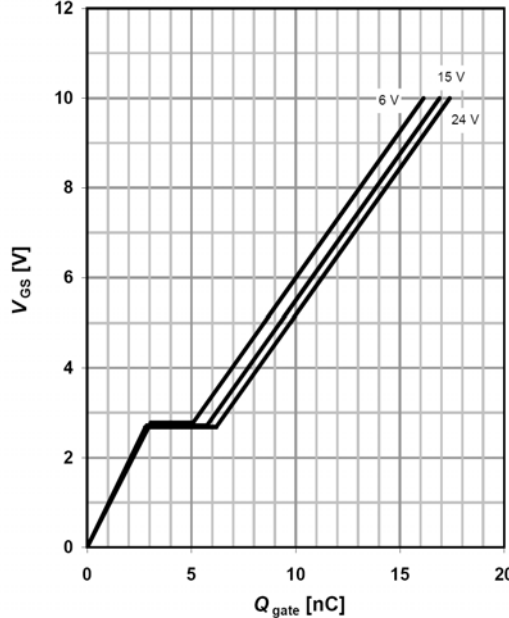
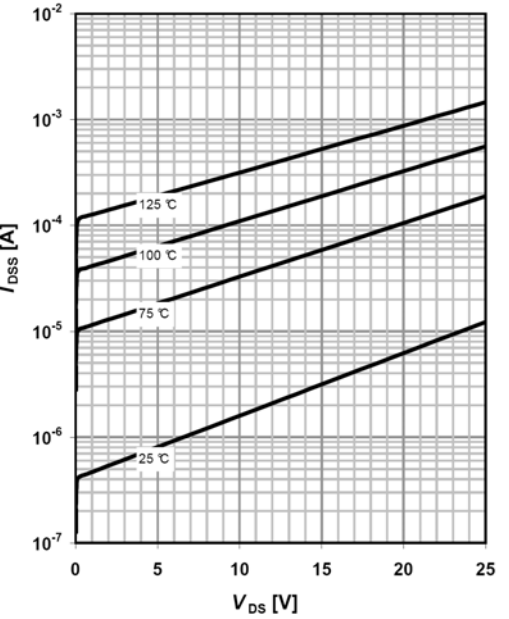
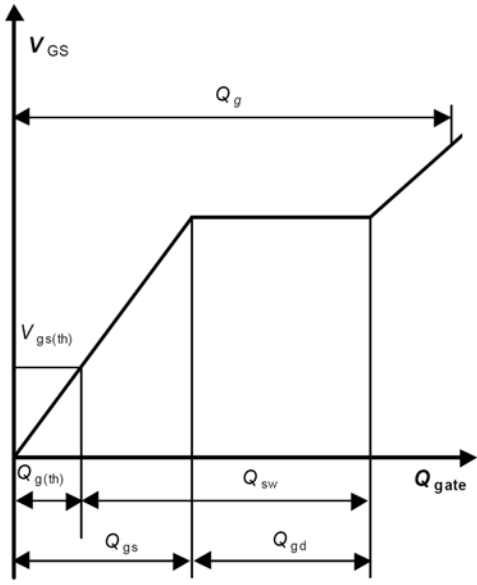
13 Avalanche characteristics	14 Typ. gate charge
 $I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega; \text{parameter: } T_{j(\text{start})}$	 $V_{GS}=f(Q_{\text{gate}}); I_D=30\ \text{A pulsed}; \text{parameter: } V_{DD}$

Table 15

15 Typ. drain-source leakage current	16 Gate charge waveforms
 $I_{DSS}=f(V_{DS}); V_{GS}=0\ \text{V}$	

6 Package outline

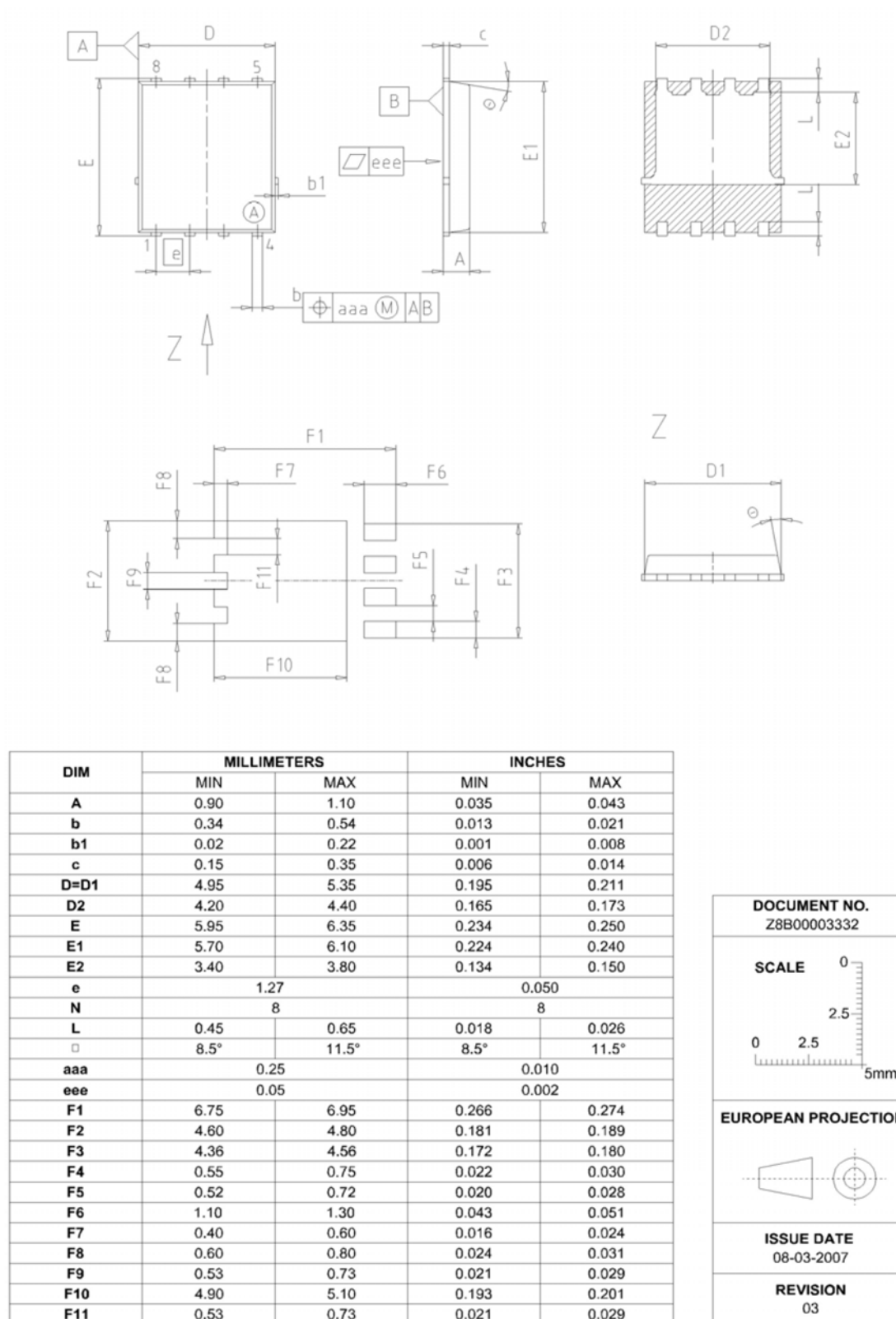


Figure 1 Outlines PG-TDSON-8, dimensions in mm/inches

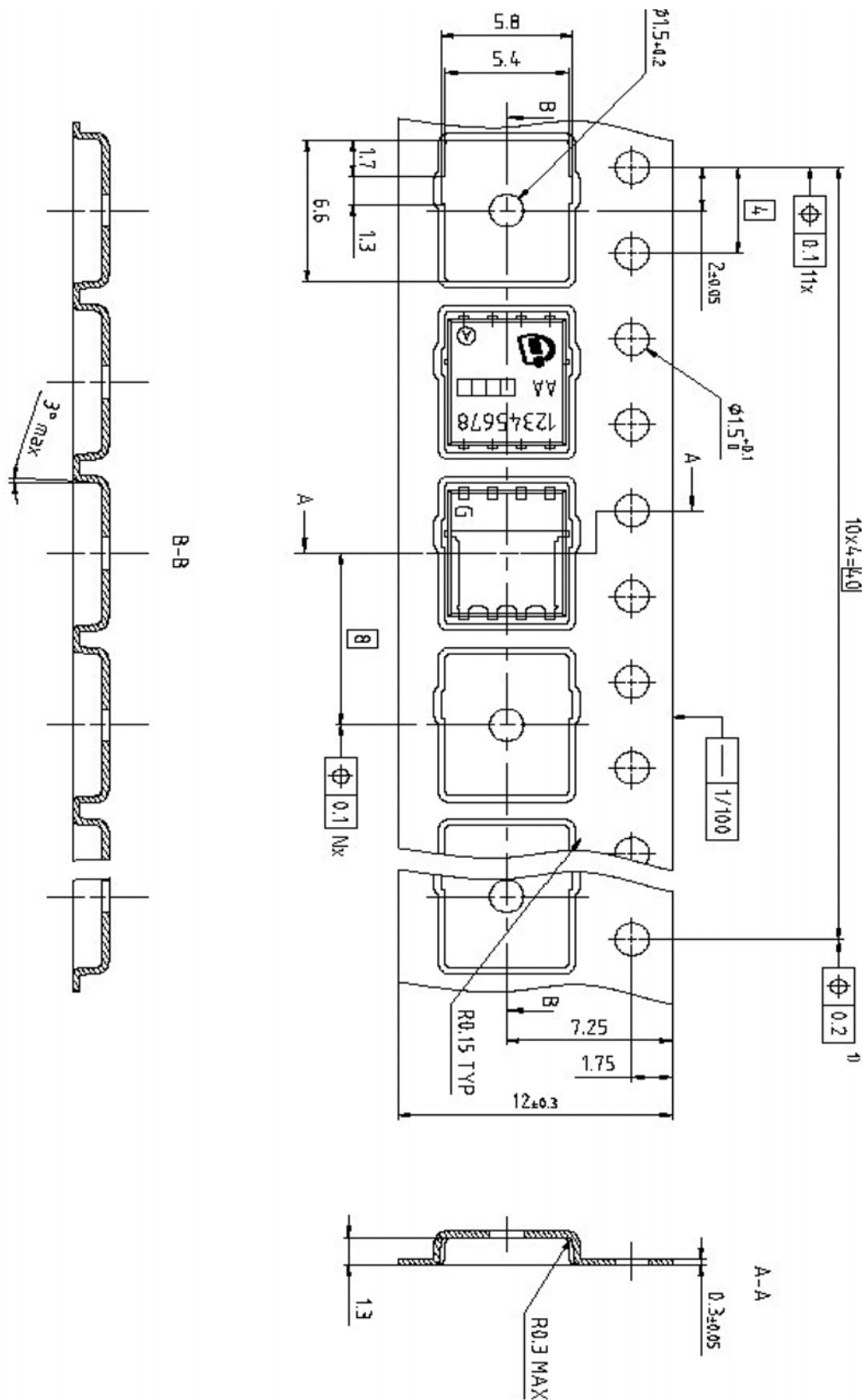


Figure 2 Outlines PG-TDSON-8 tape, dimension in mm/inches

7 Revision History

Revision History: 2011-09-23, 2.2

Previous Revision:

Revision	Subjects (major changes since last revision)
0.1	Release of target data sheet
2.0	Release of final data sheet
2.1	Update schematic
2.2	Update VGS(th)

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